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036140/US - 475387-00020 PATENT


IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inventor(s) : Guillermo J. Tearney et al.  
Serial No. : 10/765,430  
Filed : January 26, 2004  
Entitled : SYSTEM AND METHOD FOR IDENTIFYING TISSUE USING  
LOW-COHERENCE INTERFEROMETRY  
Group Art Unit : 3737  
Examiner : To be assigned

INFORMATION DISCLOSURE STATEMENT

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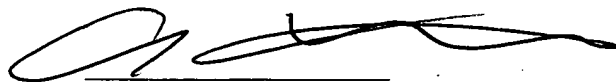
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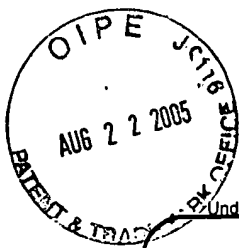
Respectfully submitted,

**DORSEY & WHITNEY, LLP**



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4848-5070-3104\1



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<b>TRANSMITTAL FORM</b>  (to be used for all correspondence after initial filing)	Application Number	10/765,430
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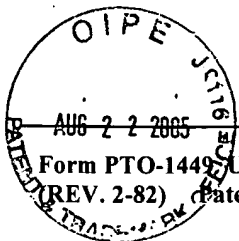
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(REV. 2-82) Patent and Trademark OfficeAtty. Docket No.  
036140/US - 475387-00020Serial No.  
10/765,430**INFORMATION DISCLOSURE STATEMENT  
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(Use several sheets if necessary)

Applicant(s)  
Guillermo J. TearneyFiling Date  
January 26, 2004Group  
3737**U.S. PATENT DOCUMENTS**

*Exam. Init.	Document No.	Date	Name	Class	Subclass	Filing Date if Appropriate
	6 6 8 5 8 8 5	February 3, 2004	Nolte et al.			
	6 6 8 7 0 0 7	February 3, 2004	Meigs			
2003	0 0 2 6 7 3 5	February 6, 2003	Nolte et al.			
2004	0 1 6 6 5 9 3	August 26, 2004	Nolte et al.			

**FOREIGN PATENT DOCUMENT**

Document No.	Date	Country	Class	SubClass	Translator Yes No

**OTHER DOCUMENTS (including Author, Title Date, Pertinent Pages, Etc.)**

	Abbas, G.L., V.W.S. Chan et al., "Local-Oscillator Excess-Noise Suppression for Homodyne and Heterodyne-Detection", <u>Optics Letters</u> , Vol. 8, pages 419-421, August 1983 issue
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